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| Notice of References Cited | Application/Control No. 10/765,189 | Applicant(s)/Patent Under Reexamination HASHIMOTO ET AL. | |
| | Examiner Weilun Lo | Art Unit 3747 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,622,709 B2 | 09-2003 | Miller et al. | 123/516 |
| | B | US-6,422,207 B1 | 07-2002 | Kolb et al. | 123/461 |
| | C | US-5,855,197 A | 01-1999 | Kato, Masahiko | 123/516 |
| | D | US-5,730,106 A | 03-1998 | Gonzalez, Jose M. | 123/516 |
| | E | US-5,579,740 A | 12-1996 | Cotton et al. | 123/516 |
| | F | US-5,355,860 A | 10-1994 | Ekstam, Charles L. | 123/516 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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